



## N-Channel and N-Channel Complementary MOSFET

### Product Summary

$V_{DS}$	40V
$I_D$	30A
$R_{DS(ON)}$ ( at $V_{GS}=10V$ )	13m
$R_{DS(ON)}$ ( at $V_{GS}=4.5V$ )	20m
100% EAS Tested	
100% $V_{DS}$ Tested	

### General Description

Trench Power MV MOSFET technology  
Excellent package for heat dissipation  
High density cell design for low  $R_{DS(ON)}$   
Moisture Sensitivity Level 1  
Epoxy Meets UL 94 V-0 Flammability Rating  
Halogen Free

### Applications

Power switching application  
Uninterruptible power supply



# YJGD30N04A

## Electrical Characteristics ( $T_J=25$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40	-	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=40V, V_{GS}=0V$	-	-	1	$\mu A$



## Typical Electrical and Thermal Characteristics Diagrams

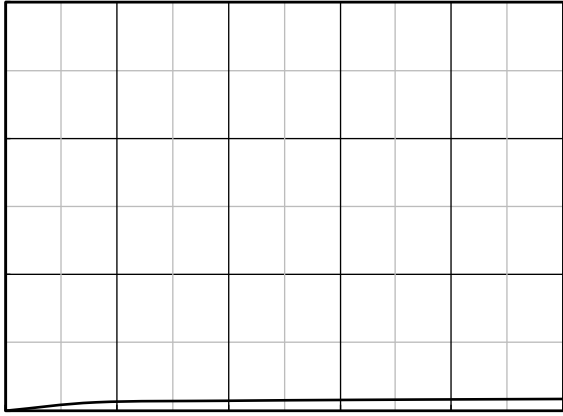


Figure 1. Output Characteristics

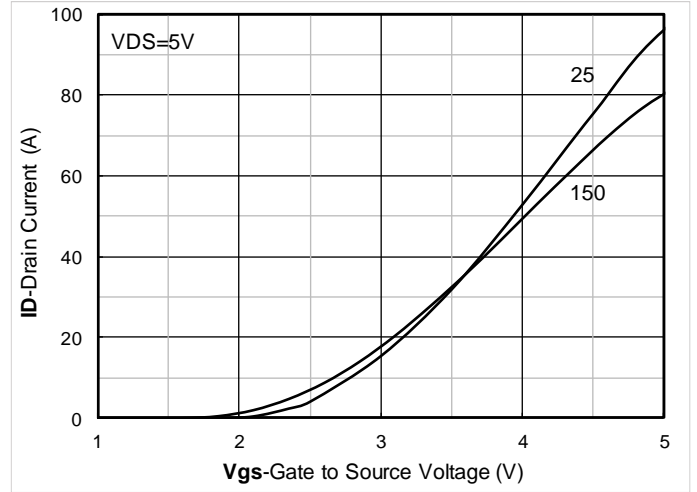


Figure 2. Transfer Characteristics

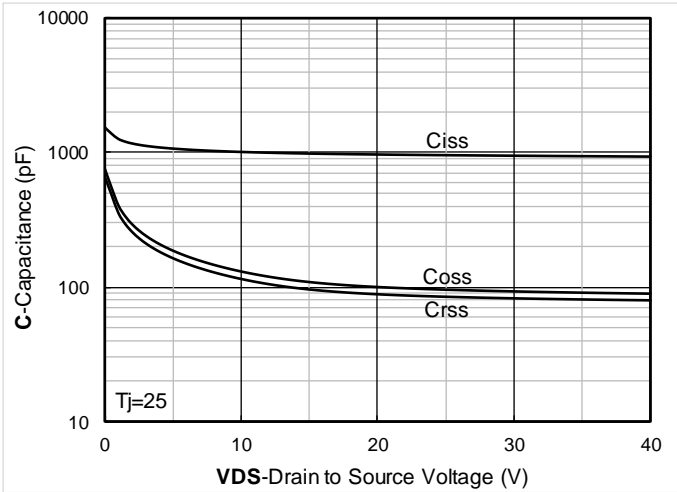


Figure 3. Capacitance Characteristics

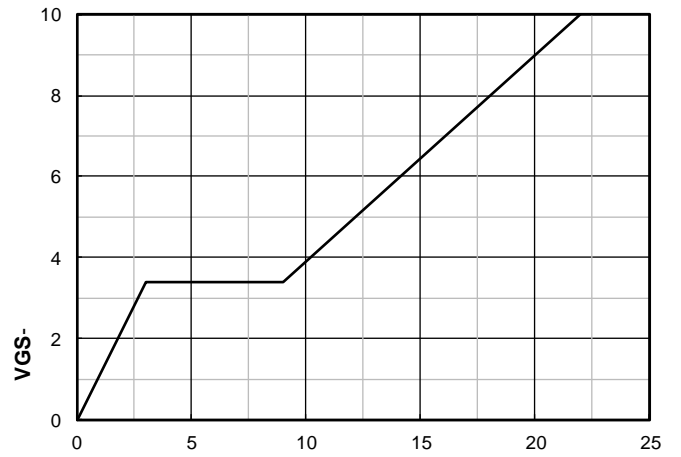


Figure 4. Gate Charge

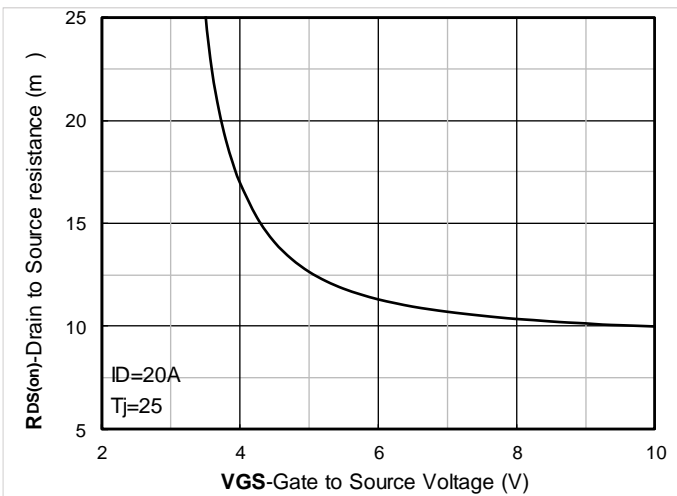
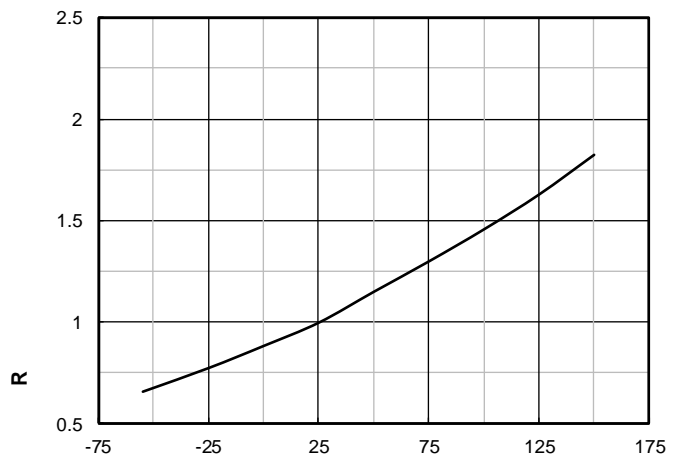


Figure 5. On-Resistance vs Gate to Source



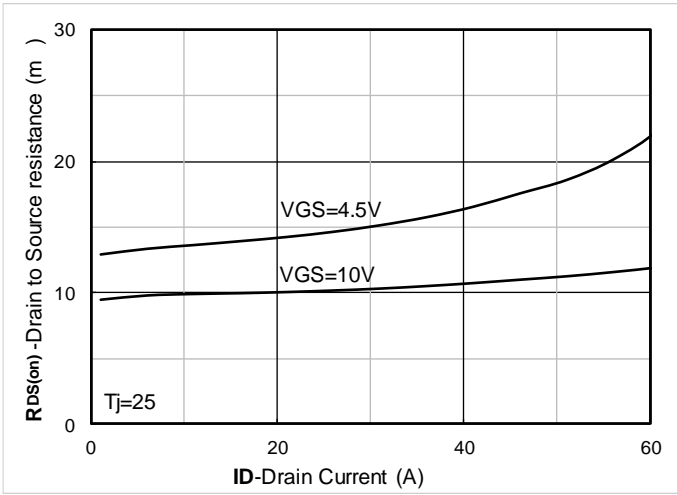


Figure 7.



# YJGD30N04A

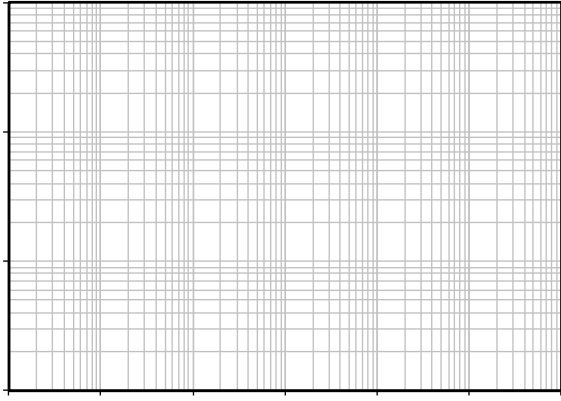


Figure 13. Maximum Transient Thermal Impedance

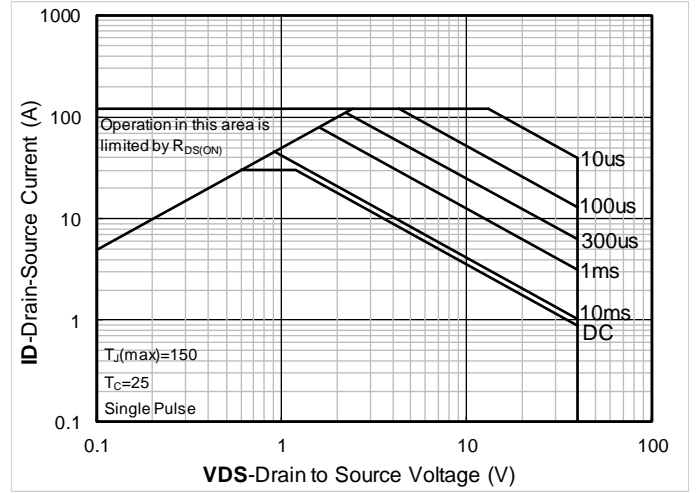


Figure 14. Safe Operation Area

## Test Circuits & Waveforms

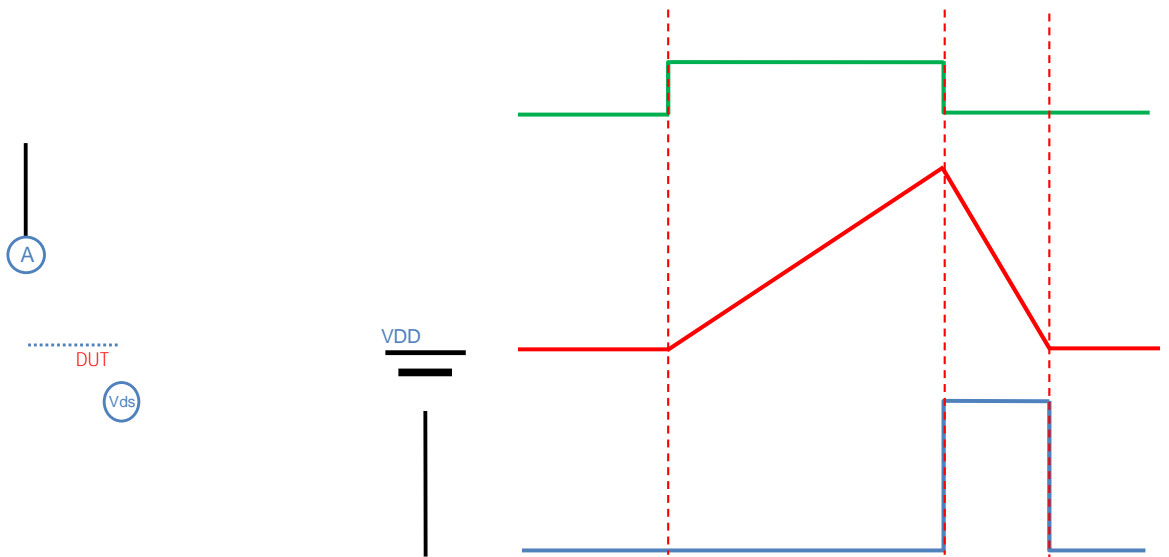


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



# YJGD30N04A

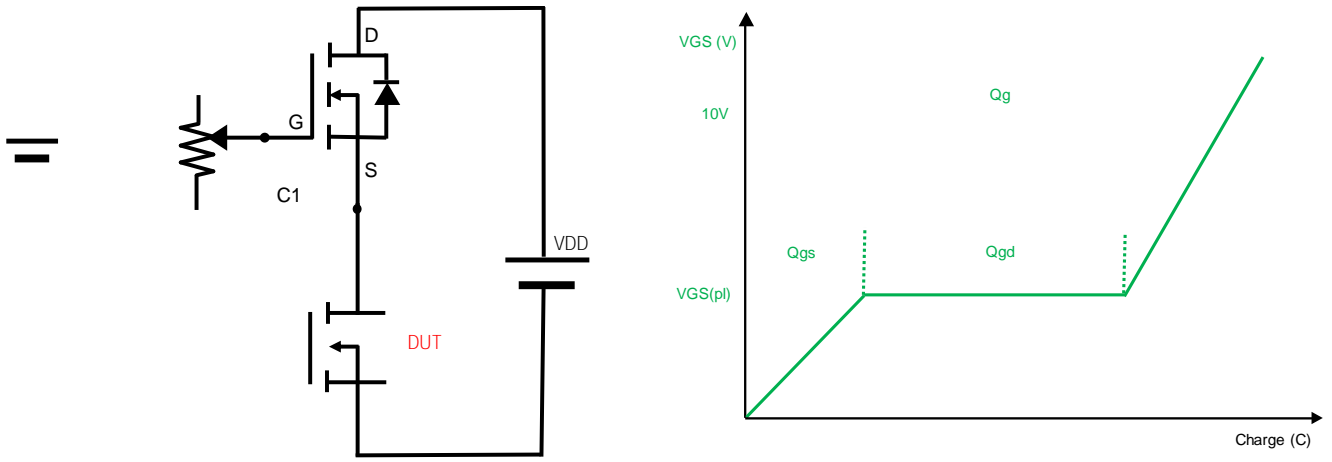
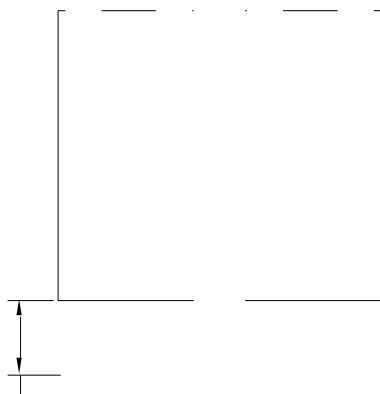


Figure B. Gate Charge Test Circuit & Waveform



PDFN5060-8L-E-1.1MM Package information



Suggested Solder Pad Layout  
Top View

Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.10\text{mm}$ .
3. The pad layout is for reference purposes only.

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